## Application/Control No. Applicant(s)/Patent Under Reexamination HINO ET AL. Examiner TAN N TRAN Applicant(s)/Patent Under Reexamination HINO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,031,257	02-2000	Noto et al.	257/202
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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## **NON-PATENT DOCUMENTS**

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